Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/666,952	CHOI ET AL.	
Examiner	Art Unit	
Naheed Ejaz	2611	

SEARCHED					
Class	Subclass	Date	Examiner		
375	130,140, 141,145, 259,260 261	4/6/2007	NE		
375	262,265	4/6/2007	NE		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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DATE	EXMR
. 4/6/2007	NE
4/5/2007	NE
	. 4/6/2007